

IRFP250

N-CHANNEL 200V - 0.073Ω - 33A TO-247 PowerMesh™II MOSFET

| TYPE | PE V _{DSS} R _{DS(} | | I _D |
|---------|--------------------------------------|----------|----------------|
| IRFP250 | 200V | < 0.085Ω | 33 A |

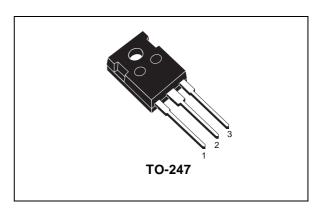
- TYPICAL $R_{DS}(on) = 0.073\Omega$
- EXTREMELY HIGH dv/dt CAPABILITY
- 100% AVALANCHE TESTED
- NEW HIGH VOLTAGE BENCHMARK
- GATE CHARGE MINIMIZED

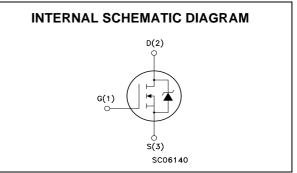
DESCRIPTION

The PowerMESHTMII is the evolution of the first generation of MESH OVERLAYTM. The layout refinements introduced greatly improve the Ron*area figure of merit while keeping the device at the leading edge for what concerns swithing speed, gate charge and ruggedness.

APPLICATIONS

- HIGH CURRENT, HIGH SPEED SWITCHING
- UNINTERRUPTIBLE POWER SUPPLIES (UPS)
- DC-AC CONVERTERS FOR TELECOM, INDUSTRIAL, AND LIGHTING EQUIPMENT





ABSOLUTE MAXIMUM RATINGS

| Symbol | Parameter | Value | Unit |
|---------------------|--|------------|------|
| V _{DS} | Drain-source Voltage (V _{GS} = 0) | 200 | V |
| V_{DGR} | Drain-gate Voltage ($R_{GS} = 20 \text{ k}\Omega$) | 200 | V |
| V _{GS} | Gate- source Voltage | ±20 | V |
| I _D | Drain Current (continuos) at T _C = 25°C | 33 | А |
| I _D | Drain Current (continuos) at T _C = 100°C | 20 | А |
| I _{DM} (●) | Drain Current (pulsed) | 132 | А |
| Ртот | Total Dissipation at T _C = 25°C | 180 | W |
| | Derating Factor | 1.44 | W/°C |
| dv/dt(1) | Peak Diode Recovery voltage slope | 5 | V/ns |
| T _{stg} | Storage Temperature | -65 to 150 | °C |
| Tj | Max. Operating Junction Temperature | 150 | °C |

(•)Pulse width limited by safe operating area

 $(1)I_{SD} \leq \! 33A, \; di/dt \leq \! 300A/\mu s, \; V_{DD} \leq V_{(BR)DSS}, \; T_j \leq T_{JMAX}.$

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THERMAL DATA

| Rthj-case | Thermal Resistance Junction-case Max | 0.66 | °C/W |
|----------------|--|------|------|
| Rthj-amb | Thermal Resistance Junction-ambient Max | 30 | °C/W |
| Rthc-sink | Thermal Resistance Case-sink Typ | 0.1 | °C/W |
| T _I | Maximum Lead Temperature For Soldering Purpose | 300 | °C |

AVALANCHE CHARACTERISTICS

| Symbol | Parameter Max Value | | Unit |
|-----------------|--|-----|------|
| I _{AR} | Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by T_j max) | 33 | А |
| Eas | Single Pulse Avalanche Energy (starting $T_j = 25$ °C, $I_D = I_{AR}$, $V_{DD} = 50$ V) | 600 | mJ |

ELECTRICAL CHARACTERISTICS (TCASE = 25 °C UNLESS OTHERWISE SPECIFIED) OFF

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Unit |
|----------------------|--|-------------------------------------|------|------|------|------|
| V _{(BR)DSS} | Drain-source Breakdown Voltage | $I_D = 250 \ \mu A, \ V_{GS} = 0$ | 200 | | | V |
| I _{DSS} | Zero Gate Voltage | V _{DS} = Max Rating | | | 1 | μA |
| | Drain Current (V _{GS} = 0) | $V_{DS} = Max Rating, T_C = 125 °C$ | | | 50 | μΑ |
| I _{GSS} | Gate-body Leakage Current (V _{DS} = 0) | V _{GS} = ±30V | | | ±100 | nA |

ON (1)

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Unit |
|---------------------|-----------------------------------|--|------|-------|-------|------|
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$ | 2 | 3 | 4 | V |
| R _{DS(on)} | Static Drain-source On Resistance | V _{GS} = 10V, I _D = 16A | | 0.073 | 0.085 | Ω |
| I _{D(on)} | On State Drain Current | $V_{DS} > I_{D(on)} \times R_{DS(on)max},$ $V_{GS} = 10V$ | 33 | | | Α |

DYNAMIC

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Unit |
|------------------|---------------------------------|---|------|------|------|------|
| 9fs | Forward Transconductance | $V_{DS} > I_{D(on)} \times R_{DS(on)max},$ $I_D = 16A$ | 10 | 25 | | S |
| C _{iss} | Input Capacitance | $V_{DS} = 25V, f = 1 \text{ MHz}, V_{GS} = 0$ | | 2850 | | pF |
| Coss | Output Capacitance | | | 420 | | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 120 | | pF |

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ELECTRICAL CHARACTERISTICS (CONTINUED)

SWITCHING ON

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Unit |
|--------------------|--------------------|--|------|------|------|------|
| t _{d(on)} | Turn-on Delay Time | V _{DD} = 100V, I _D =16 A | | 25 | | ns |
| t _r | Rise Time | $^{\prime}$ R _G = 4.7 Ω , V _{GS} = 10V (see test circuit, Figure 3) | | 50 | | ns |
| Qg | Total Gate Charge | $V_{DD} = 160V, I_D = 33 A,$ | | 117 | 158 | nC |
| Q_{gs} | Gate-Source Charge | $V_{GS} = 10V$, $R_G = 4.7\Omega$ | | 15 | | nC |
| Q_{gd} | Gate-Drain Charge | | | 50 | | nC |

SWITCHING OFF

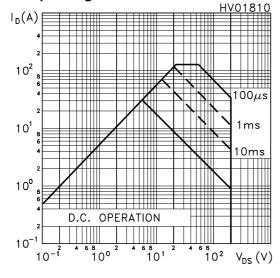
| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Unit |
|----------------------|-----------------------|--|------|------|------|------|
| t _{r(Voff)} | Off-voltage Rise Time | V _{DD} = 160V, I _D = 16 A, | | 60 | | ns |
| t _f | Fall Time | $R_G = 4.7\Omega$, $V_{GS} = 10V$ (see test circuit, Figure 5) | | 40 | | ns |
| t _c | Cross-over Time | (occ test should, 1 igure o) | | 100 | | ns |

SOURCE DRAIN DIODE

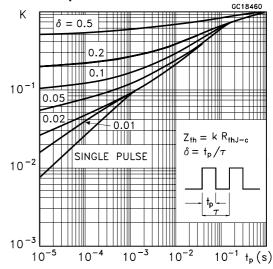
| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Unit |
|----------------------|-------------------------------|--|------|------|------|------|
| I _{SD} | Source-drain Current | | | | 33 | Α |
| I _{SDM} (2) | Source-drain Current (pulsed) | | | | 132 | Α |
| V _{SD} (1) | Forward On Voltage | I _{SD} = 33 A, V _{GS} = 0 | | | 1.6 | V |
| t _{rr} | Reverse Recovery Time | $I_{SD} = 33 \text{ A}, \text{ di/dt} = 100 \text{A/} \mu \text{s},$ | | 370 | | ns |
| Q _{rr} | Reverse Recovery Charge | $V_{DD} = 100V$, $T_j = 150$ °C (see test circuit, Figure 5) | | 5.4 | | μC |
| I _{RRM} | Reverse Recovery Current | (300 tost offourt, 1 igure 3) | | 29 | | Α |

Note: 1. Pulsed: Pulse duration = 300 μs, duty cycle 1.5 %.
2. Pulse width limited by safe operating area.

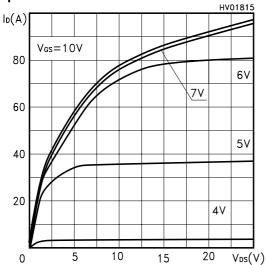
Safe Operating Area



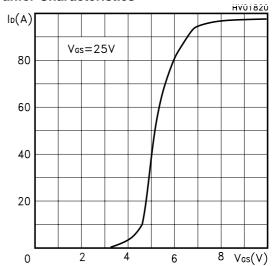
Thermal Impedance



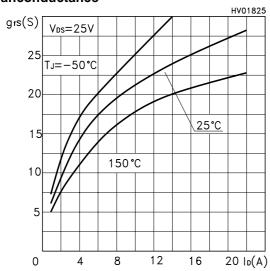
Output Characteristics



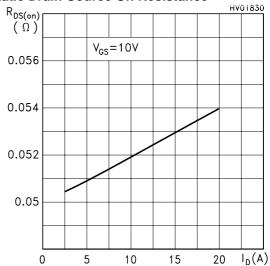
Tranfer Characteristics



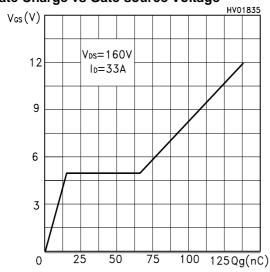
Tranconductance



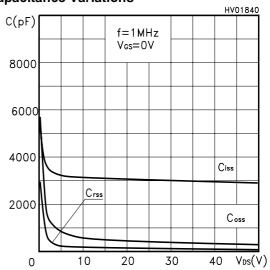
Static Drain-Source On Resistance



Gate Charge vs Gate-source Voltage

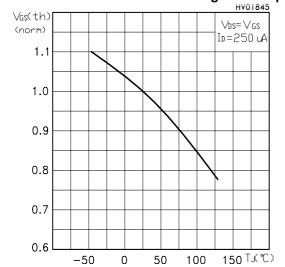


Capacitance Variations

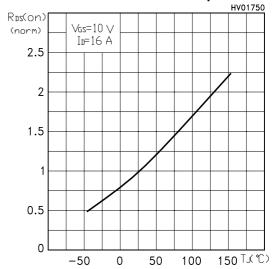


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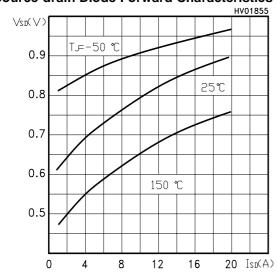
Normalized Gate Thereshold Voltage vs Temp.



Normalized On Resistance vs Temperature



Source-drain Diode Forward Characteristics



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Fig. 1: Unclamped Inductive Load Test Circuit

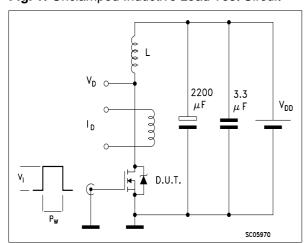


Fig. 3: Switching Times Test Circuit For Resistive Load

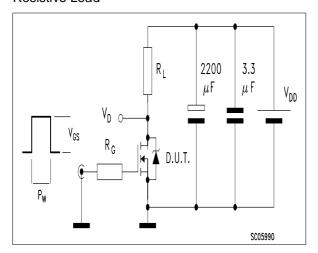


Fig. 5: Test Circuit For Inductive Load Switching And Diode Recovery Times

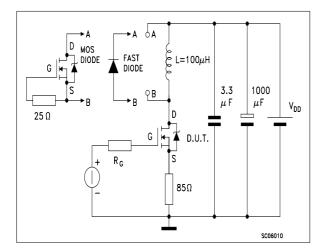


Fig. 2: Unclamped Inductive Waveform

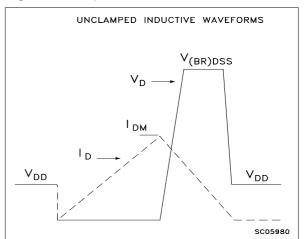
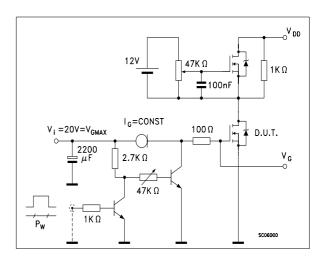


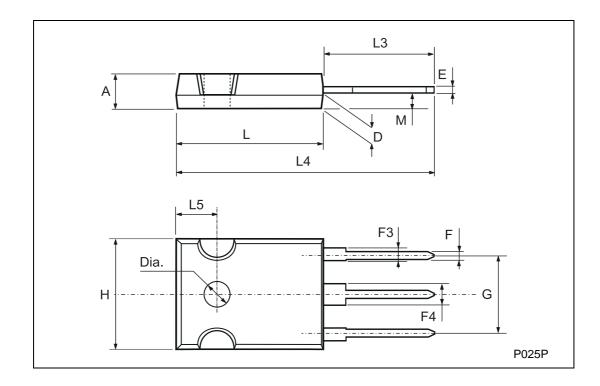
Fig. 4: Gate Charge test Circuit



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TO-247 MECHANICAL DATA

| DIM. | | mm | | | inch | |
|--------|------|------|------|-------|-------|-------|
| Dilvi. | MIN. | TYP. | MAX. | MIN. | TYP. | MAX. |
| А | 4.7 | | 5.3 | 0.185 | | 0.209 |
| D | 2.2 | | 2.6 | 0.087 | | 0.102 |
| Е | 0.4 | | 0.8 | 0.016 | | 0.031 |
| F | 1 | | 1.4 | 0.039 | | 0.055 |
| F3 | 2 | | 2.4 | 0.079 | | 0.094 |
| F4 | 3 | | 3.4 | 0.118 | | 0.134 |
| G | | 10.9 | | | 0.429 | |
| Н | 15.3 | | 15.9 | 0.602 | | 0.626 |
| L | 19.7 | | 20.3 | 0.776 | | 0.779 |
| L3 | 14.2 | | 14.8 | 0.559 | | 0.582 |
| L4 | | 34.6 | | | 1.362 | |
| L5 | | 5.5 | | | 0.217 | |
| М | 2 | | 3 | 0.079 | | 0.118 |



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